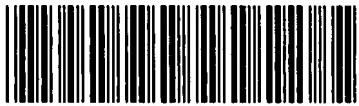


<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10707003	BENTWICH, ITZHAK
Examiner	Art Unit	
Shin, Dana	1635	

### SEARCHED

Class	Subclass	Date	Examiner
536	23.1, 24.5	6-27-07, 9-5-07	DS
435	6	6-27-07, 9-5-07	DS

### SEARCH NOTES

Search Notes	Date	Examiner
STIC - SEQ ID NOS: 3588 (Score over length) search results available on SCORE	6-26-07	DS
EAST - updated	6-27-07, 9-5-07	DS
PALM - inventor name search	6-27-07	DS

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner